The following Listing of Claims will replace all prior versions, and listing

of claims in the Application.

<u>Listing of Claims</u>:

1. (Withdrawn) An anti-microbial sanitary ware comprising:

a substrate; and

an anti-microbial film formed on said substrate and comprising a

protective layer and anti-microbial metal particles that are dispersed in said

protective layer;

wherein said protective layer is made from a compound selected

from the group consisting of metal nitrides and metal carbides; and

wherein said anti-microbial metal particles are made from a metal

selected from the group consisting of silver, zinc, and copper.

2. (Withdrawn) The anti-microbial sanitary ware of Claim 1, wherein said

compound of said protective layer is metal nitride.

3. (Withdrawn) The anti-microbial sanitary ware of Claim 2, wherein said

compound is selected from the group consisting of zirconium nitride, chromium

nitride, and titanium nitride.

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- 4. (Withdrawn) The anti-microbial sanitary ware of Claim 3, wherein said compound is zirconium nitride.
- 5. (Withdrawn) The anti-microbial sanitary ware of Claim 4, wherein said substrate is made from a material selected from the group consisting of copper alloy, zinc alloy, stainless steel, ceramics, and plastics.
- 6. (Withdrawn) The anti-microbial sanitary ware of Claim 5, wherein said substrate is made from copper alloy.
- 7. (Currently Amended) A method for making an anti-microbial sanitary ware, comprising the steps of:

placing a substrate in a sputtering chamber in a sputter; and simultaneously sputtering a first metal target of a first metal and a second metal target of a second metal through closed-field unbalanced magnetron sputtering techniques; , which form

forming a continuously closed magnetic field around the substrate; ; so as to react

reacting the first metal into a metal compound which is and subsequently depositing said metal compound deposited on the substrate thereby forming to form a protective layer; and

generating, and so as to generate metal particles of the second metal having a size of less than 100 nanometers and dispersing said metal particles that are dispersed in the protective layer;

wherein the second metal is selected from the group consisting of silver, zinc, and copper; and

wherein the metal compound is selected from the group consisting of metal nitrides and metal carbides.

- 8. (Original) The method of Claim 7, wherein the first metal is selected from the group consisting of zirconium, chromium, and titanium.
- 9. (Original) The method of Claim 8, wherein the metal compound is selected from the group consisting of zirconium nitride, chromium nitride, and titanium nitride.
- 10. (Original) The method of Claim 9, wherein the substrate is made from a material selected from the group consisting of copper alloy, zinc alloy, stainless steel, ceramics, and plastics.

- 11. (Original) The method of Claim 10, wherein the sputtering for the first metal target is conducted at a voltage ranging from 20-50V, and a current ranging from 3.5-4.5A.
- 12. (Original) The method of Claim 11, wherein the sputtering for the second metal target is conducted at a voltage of less than 20V, and a current ranging from 0.3-0.5A.
- 13. (Original) The method of Claim 12, wherein the sputtering is conducted at a temperature ranging from 80-180°.
- 14. (Original) The method of Claim 13, wherein the sputtering is conducted at a pressure ranging from 0.1-20 mTorr.
- 15. (Original) The method of Claim 14, wherein the sputtering time ranges from 3-13 minutes.